

Si8410/20/21 (5 kV) Si8422/23/24/25/26 (2.5 & 5 kV) Data Sheet

Low-Power, Single and Dual-Channel Digital Isolators

Skyworks' family of ultra-low-power digital isolators are CMOS devices offering substantial data rate, propagation delay, power, size, reliability, and external BOM advantages when compared to legacy isolation technologies. The operating parameters of these products remain stable across wide temperature ranges and throughout device service life for ease of design and highly uniform performance. All device versions have Schmitt trigger inputs for high noise immunity and only require V_{DD} bypass capacitors.

Data rates up to 150 Mbps are supported, and all devices achieve worst-case propagation delays of less than 10 ns. Ordering options include a choice of isolation ratings (up to 5 kV) and a selectable fail-safe operating mode to control the default output state during power loss. All products are safety certified by UL, CSA, and VDE, and products in wide-body packages support reinforced insulation withstanding up to 5 kV_{RMS}.

Applications

- · Industrial automation systems
- · Medical electronics
- Hybrid electric vehicles
- · Isolated switch mode supplies

Safety Regulatory Approvals

- UL 1577 recognized
 - + Up to 5000 $V_{\mbox{RMS}}$ for 1 minute
- CSA component notice 5A approval
 - IEC 60950-1, 61010-1, 60601-1 (reinforced insulation)

- Isolated ADC, DAC
- Motor control
- · Power inverters
- Communication systems
- · VDE certification conformity
 - IEC 60747-5-5 (VDE0884 Part 5)
 - EN60950-1 (reinforced insulation)

KEY FEATURES

- High-speed operation
 DC to 150 Mbps
- No start-up initialization required
- Wide Operating Supply Voltage:
 2.6 5.5 V
- Up to 5000 V_{RMS} isolation
- · High electromagnetic immunity
- Ultra low power (typical)
 - 5 V Operation:
 - < 2.6 mA/channel at 1 Mbps</p>
 - < 6.8 mA/channel at 100 Mbps</p>
 - 2.70 V Operation:
 - < 2.3 mA/channel at 1 Mbps</p>
 - < 4.6 mA/channel at 100 Mbps
- · Schmitt trigger inputs
- Selectable fail-safe mode
- · Default high or low output
- Precise timing (typical)
 - · 11 ns propagation delay max
 - 1.5 ns pulse width distortion
 - 0.5 ns channel-channel skew
 - · 2 ns propagation delay skew
- 5 ns minimum pulse width
- Transient immunity 45 kV/µs
- AEC-Q100 qualification
- Wide temperature range
- –40 to 125 °C at 150 Mbps

- RoHS compliant packages
 - SOIC-16 wide body
 - SOIC-8 narrow body

1. Features List

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 - DC to 150 Mbps
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2. Ordering Guide

Table 2.1.	Ordering	Guide ^{1,2,3}
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Ordering Part Number (OPN)	Number of Inputs VDD1 Side	Number of Inputs VDD2 Side	Maximum Data Rate (Mbps)	Default Output State	Isolation Rating	Temp Range	Package Type
Si8422AB-D-IS	1	1	1	High	2.5 kVrms	–40 to 125 °C	NB SOIC-8
Si8422BB-D-IS	1	1	150	High			
Si8423AB-D-IS	2	0	1	High			
Si8423BB-D-IS	2	0	150	High			
Si8424AB-D-IS	2	0	1	Low			
Si8424BB-D-IS	2	0	150	Low			
Si8425AB-D-IS	1	1	1	High			
Si8425BB-D-IS	1	1	150	High			
Si8426AB-D-IS	1	1	1	Low			
Si8426BB-D-IS	1	1	150	Low			
Si8410AD-D-IS ⁴	1	0	1	Low	5.0 kVrms	–40 to 125 °C	WB SOIC-16
Si8410BD-D-IS ⁴	1	0	150	Low	-		
Si8420AD-D-IS ⁴	2	0	1	Low			
Si8420BD-D-IS ⁴	2	0	150	Low			
Si8421AD-D-IS ⁴	1	1	1	Low	-		
Si8421BD-D-IS ⁴	1	1	150	Low	-		
Si8422AD-D-IS	1	1	1	High	1		
Si8422BD-D-IS	1	1	150	High			
Si8423AD-D-IS	2	0	1	High			
Si8423BD-D-IS	2	0	150	High			

1. All devices >1 kV_{RMS} are AEC-Q100 qualified.

2. "Si" and "SI" are used interchangeably.

3. All packages are RoHS-compliant with peak solder reflow temperatures of 260 °C according to the JEDEC industry standard classifications.

4. Refer to Si8410/20/21 data sheet for information regarding 2.5 kV rated versions of these products.

5. An "R" at the end of the part number denotes tape and reel packaging option.

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3. Functional Description

3.1 Theory of Operation

The operation of an Si84xx channel is analogous to that of an opto coupler, except an RF carrier is modulated instead of light. This simple architecture provides a robust isolated data path and requires no special considerations or initialization at start-up. A simplified block diagram for a single Si84xx channel is shown in the figure below.

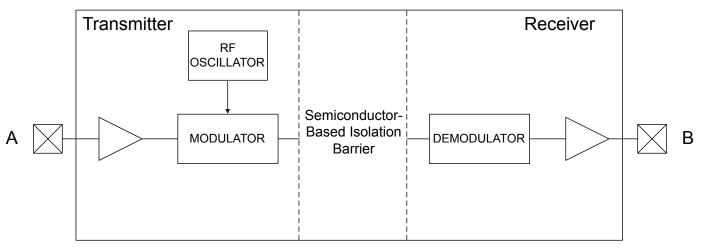


Figure 3.1. Simplified Channel Diagram

A channel consists of an RF Transmitter and RF Receiver separated by a semiconductor-based isolation barrier. Referring to the Transmitter, input A modulates the carrier provided by an RF oscillator using on/off keying. The Receiver contains a demodulator that decodes the input state according to its RF energy content and applies the result to output B via the output driver. This RF on/off keying scheme is superior to pulse code schemes as it provides best-in-class noise immunity, low power consumption, and better immunity to magnetic fields. See the figure below for more details.

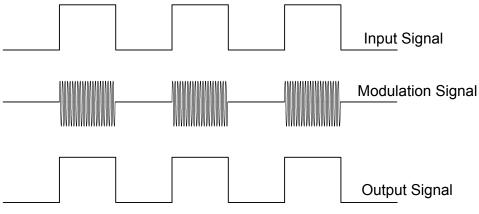


Figure 3.2. Modulation Scheme

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3.2 Eye Diagram

The figure below illustrates an eye-diagram taken on an Si8422. For the data source, the test used an Anritsu (MP1763C) Pulse Pattern Generator set to 1000 ns/div. The output of the generator's clock and data from an Si8422 were captured on an oscilloscope. The results illustrate that data integrity was maintained even at the high data rate of 150 Mbps. The results also show that 2 ns pulse width distortion and 350 ps peak jitter were exhibited.

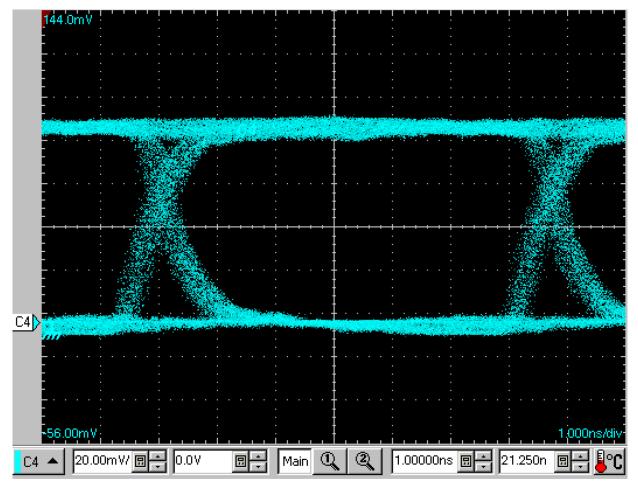


Figure 3.3. Eye Diagram

4. Device Operation

Device behavior during start-up, normal operation, and shutdown is shown in Figure 4.1 Device Behavior during Normal Operation on page 7, where UVLO+ and UVLO- are the positive-going and negative-going thresholds respectively. Refer to the table below to determine outputs when power supply (V_{DD}) is not present.

Table 4.1.	Si84xx	Logic	Operation	Table
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V _I Input ^{1,4}	VDDI State ^{1,2,3}	VDDO State ^{1,2,3}	V _O Output ^{1,4}	Comments
Н	Р	Р	Н	Normal operation.
L	Р	Р	L	
X ⁵	UP	Ρ	H ⁶ (Si8422/23) L ⁶ (Si8410/20/21)	Upon transition of VDDI from unpowered to powered, V_O returns to the same state as V_I in less than 1 $\mu s.$
X ⁵	Р	UP	Undetermined	Upon transition of VDDO from unpowered to powered, V_O returns to the same state as V_I within 1 $\mu s.$

Notes:

1. VDDI and VDDO are the input and output power supplies. VI and VO are the respective input and output terminals.

2. Powered (P) state is defined as 2.72.60 V < VDD < 5.5 V.

3. Unpowered (UP) state is defined as VDD = 0 V.

4. X = not applicable; H = Logic High; L = Logic Low.

5. Note that an I/O can power the die for a given side through an internal diode if its source has adequate current.

6. See Section 2. Ordering Guide for details. This is the selectable fail-safe operating mode (ordering option). Some devices have default output state = H, and some have default output state = L, depending on the ordering part number (OPN).

4.1 Device Startup

Outputs are held low during powerup until V_{DD} is above the UVLO threshold for time period tSTART. Following this, the outputs follow the states of inputs.

4.2 Under Voltage Lockout

Under Voltage Lockout (UVLO) is provided to prevent erroneous operation during device startup and shutdown or when V_{DD} is below its specified operating circuits range. Both Side A and Side B each have their own undervoltage lockout monitors. Each side can enter or exit UVLO independently. For example, Side A unconditionally enters UVLO when V_{DD1} falls below $V_{DD1(UVLO-)}$ and exits UVLO when V_{DD1} rises above $V_{DD1(UVLO+)}$. Side B operates the same as Side A with respect to its V_{DD2} supply.

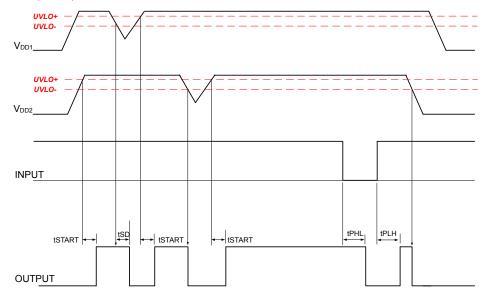


Figure 4.1. Device Behavior during Normal Operation

4.3 Layout Recommendations

To ensure safety in the end user application, high voltage circuits (i.e., circuits with >30 V_{AC}) must be physically separated from the safety extra-low voltage circuits (SELV is a circuit with <30 V_{AC}) by a certain distance (creepage/clearance). If a component, such as a digital isolator, straddles this isolation barrier, it must meet those creepage/clearance requirements and also provide a sufficiently large high-voltage breakdown protection rating (commonly referred to as working voltage protection). Table 5.5 Regulatory Information¹ on page 22 and Table 5.6 Insulation and Safety-Related Specifications on page 23 detail the working voltage and creepage/clearance capabilities of the Si84xx. These tables also detail the component standards (UL1577, IEC60747, CSA 5A), which are readily accepted by certification bodies to provide proof for end-system specifications requirements. Refer to the end-system specification (61010-1, 60950-1, 60601-1, etc.) requirements before starting any design that uses a digital isolator.

4.3.1 Supply Bypass

The Si841x/2x family requires a 0.1 μ F bypass capacitor between V_{DD1} and GND1 and V_{DD2} and GND2. The capacitor should be placed as close as possible to the package. To enhance the robustness of a design, it is further recommended that the user also add 1 μ F bypass capacitors and include 100 Ω resistors in series with the inputs and outputs if the system is excessively noisy.

4.3.2 Pin Connections

No connect pins are not internally connected. They can be left floating, tied to V_{DD}, or tied to GND.

4.3.3 Output Pin Termination

The nominal output impedance of an isolator driver channel is approximately 50 Ω , ±40%, which is a combination of the value of the on-chip series termination resistor and channel resistance of the output driver FET. When driving loads where transmission line effects will be a factor, output pins should be appropriately terminated with controlled impedance PCB traces.

4.4 Fail-Safe Operating Mode

Si84xx devices feature a selectable (by ordering option) mode whereby the default output state (when the input supply is unpowered) can either be a logic high or logic low when the output supply is powered. See Table 4.1 Si84xx Logic Operation Table on page 6 and Section 2. Ordering Guide for more information.

4.5 Typical Performance Characteristics

The typical performance characteristics depicted in the following diagrams are for information purposes only. Refer to Table 5.2 Electrical Characteristics¹ on page 19 for actual specification limits.

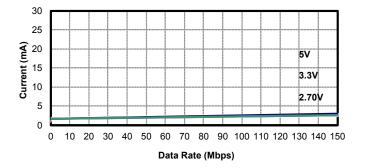
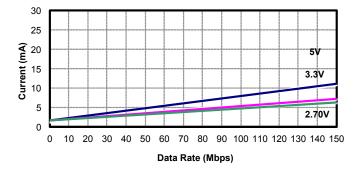
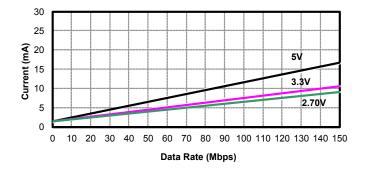
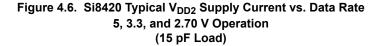


Figure 4.2. Si8410 Typical V_{DD1} Supply Current vs. Data Rate 5, 3.3, and 2.70 V Operation









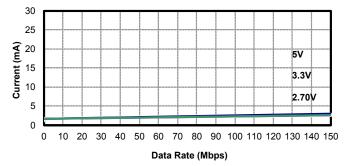
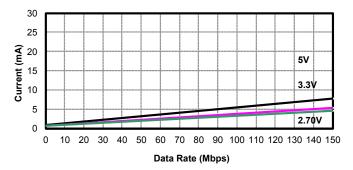
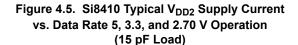


Figure 4.3. Si8420 Typical V_{DD1} Supply Current vs. Data Rate 5, 3.3, and 2.70 V Operation





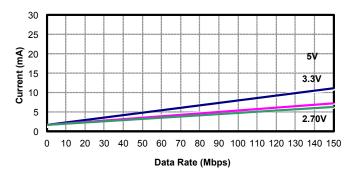


Figure 4.7. Si8422 Typical V_{DD1} or V_{DD2} Supply Current vs. Data Rate 5, 3.3, and 2.70 V Operation (15 pF Load)

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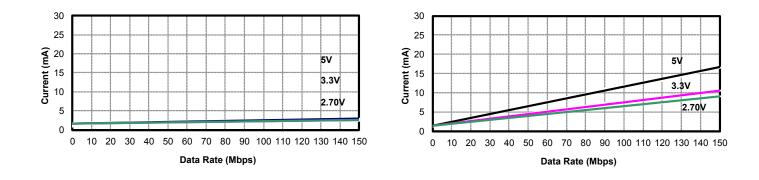
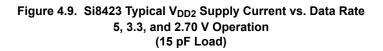
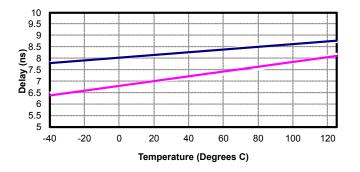
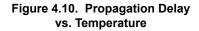


Figure 4.8. Si8423 Typical V_{DD1} Supply Current vs. Data Rate 5, 3.3, and 2.70 V Operation







5. Electrical Specifications

Table 5.1. Recommended Operating Conditions

Parameter	Symbol	Min	Тур	Мах	Unit
Ambient Operating Temperature ¹	T _A	-40	25	125	C°
Supply Voltage	V _{DD1}	2.70	_	5.5	V
	V _{DD2}	2.70	_	5.5	V
Note: 1. The maximum ambient temperature is dep supply voltage.	endent upon data freque	ncy, output load	ing, the number	of operating ch	annels, and

Table 5.2. Electrical Characteristics

(V_{DD1} = 5 V ±10%, V_{DD2} = 5 V ±10%, T_A = -40 to 125 °C)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
VDD Undervoltage Threshold	VDDUV+	V_{DD1}, V_{DD2} rising	2.15	2.3	2.5	V
VDD Negative-Going Lockout Hysteresis	VDD _{HYS}		45	75	95	mV
Positive-Going Input Threshold	VT+	All inputs rising	1.6		1.9	V
Negative-Going Input Threshold	VT–	All inputs falling	1.1		1.4	V
Input Hysteresis	V _{HYS}		0.40	0.45	0.50	V
High Level Input Voltage	V _{IH}		2.0		_	V
Low Level Input Voltage	V _{IL}				0.8	V
High Level Output Voltage	V _{OH}	loh = -4 mA	V _{DD1} ,V _{DD2} - 0.4	4.8	_	V
Low Level Output Voltage	V _{OL}	lol = 4 mA		0.2	0.4	V
Input Leakage Current	ار		_		±10	μA
Output Impedance ¹	Z _O		_	50	_	Ω
	DC Supply	Current (All inputs 0 V or	at Supply)		I.	1
Si8410Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.0	1.5	mA
V _{DD2}		All inputs 0 DC	—	3.0	1.5	
V _{DD1}		All inputs 1 DC	_	3.0	4.5	
V _{DD2}		All inputs 1 DC	_	1.0	1.5	
Si8420Ax, Bx						

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
V _{DD1}		All inputs 0 DC	_	1.3	2.0	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	5.8	8.7	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
Si8421Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.7	2.6	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	3.7	5.6	
V _{DD2}		All inputs 1 DC	_	3.7	5.6	
Si8422Ax, Bx						
V _{DD1}		All inputs 0 DC	_	3.7	5.6	mA
V _{DD2}		All inputs 0 DC	_	3.7	5.6	
V _{DD1}		All inputs 1 DC	_	1.7	2.6	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
Si8423Ax, Bx						
V _{DD1}		All inputs 0 DC	_	5.4	8.1	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	1.3	2.0	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
1 Mbps St	upply Current (All	inputs = 500 kHz square wav	e, C _L = 15 pF	on all outputs	s)	1
Si8410Ax, Bx						
V _{DD1}			_	2.0	3.0	mA
V _{DD2}			_	1.1	1.7	
Si8420Ax, Bx						
V _{DD1}			_	3.5	5.3	mA
V _{DD2}			_	1.9	2.9	
Si8421Ax, Bx						
V _{DD1}			_	2.8	4.2	mA
V _{DD2}			_	2.8	4.2	
Si8422Ax, Bx						
V _{DD1}			_	2.8	4.2	mA
V _{DD2}			_	2.8	4.2	
Si8423Ax, Bx						
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	1.9	2.9	

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Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
10 Mb	ps Supply Current (All i	nputs = 5 MHz square wav	e, C _L = 15 pF	on all outputs	s)	
Si8410Bx						
V _{DD1}			_	2.1	3.1	mA
V _{DD2}			—	1.5	2.1	
Si8420Bx						
V _{DD1}			—	3.6	5.4	mA
V _{DD2}			—	2.6	3.6	
Si8421Bx						
V _{DD1}			_	3.2	4.5	mA
V _{DD2}			_	3.2	4.5	
Si8422Bx						
V _{DD1}			_	3.2	4.5	mA
V _{DD2}			_	3.2	4.5	
Si8423Bx						
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	2.5	3.5	
	ps Supply Current (All i	nputs = 50 MHz square wa	 ve, C _L = 15 pF	[:] on all outpu	ts)	
Si8410Bx						
V _{DD1}			_	2.1	3.1	mA
V _{DD2}			_	5.0	6.3	
Si8420Bx						
V _{DD1}			_	3.7	5.4	mA
V _{DD2}			_	9.8	12.3	
Si8421Bx						
V _{DD1}			_	6.8	8.5	mA
V _{DD2}			_	6.8	8.5	
Si8422Bx						
V _{DD1}			_	6.8	8.5	mA
V _{DD2}			_	6.8	8.5	
Si8423Bx						
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	9.2	11.5	
	·	Timing Characteristics				
Si841xAx, Si842xAx						
Maximum Data Rate			0	_	1.0	Mbps

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Minimum Pulse Width			_	_	250	ns
Propagation Delay	t _{PHL} , t _{PLH}	See Figure 5.1 Propagation Delay Timing on page 14	_	-	35	ns
Pulse Width Distortion	PWD	See Figure 5.1 Propagation		_	25	ns
tplh - tphl		Delay Timing on page 14				
Propagation Delay Skew ²	t _{PSK(P-P)}		_	_	40	ns
Channel-Channel Skew	t _{PSK}			_	35	ns
Si841xBx, Si842xBx	I			J	1	1
Maximum Data Rate			0	_	150	Mbps
Minimum Pulse Width				_	6.0	ns
Propagation Delay	t _{PHL} , t _{PLH}	See Figure 5.1 Propagation Delay Timing on page 14	4.0	8.0	11	ns
Pulse Width Distortion	PWD	See Figure 5.1 Propagation	_	1.5	3.0	ns
tplh - tphl		Delay Timing on page 14				
Propagation Delay Skew ²	t _{PSK(P-P)}		_	2.0	3.0	ns
Channel-Channel Skew	t _{PSK}		_	0.5	1.5	ns
All Models	I			J	1	1
Output Rise Time	tr	C _L = 15 pF		2.0	4.0	ns
Output Fall Time	t _f	C _L = 15 pF	_	2.0	4.0	ns
Peak Eye Diagram Jitter	t _{JIT(PK)}	See Figure 3.3 Eye Diagram on page 5	_	350	-	ps
Common Mode Transient Immunity	CMTI	V _I = V _{DD} or 0 V	20	45	_	kV/µs
Start-up Time ³	t _{SU}		_	15	40	μs

Notes:

1. The nominal output impedance of an isolator driver channel is approximately 50 Ω , ±40%, which is a combination of the value of the on-chip series termination resistor and channel resistance of the output driver FET. When driving loads where transmission line effects will be a factor, output pins should be appropriately terminated with controlled impedance PCB traces.

2. t_{PSK(P-P)} is the magnitude of the difference in propagation delay times measured between different units operating at the same supply voltages, load, and ambient temperature.

3. Start-up time is the time period from the application of power to valid data at the output.

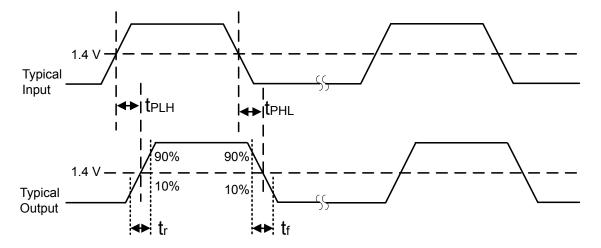


Figure 5.1. Propagation Delay Timing

Table 5.3. Electrical Characteristics

$(V_{DD1} = 3.3 \text{ V} \pm 10\%, V_{DD2} = 3.3 \text{ V} \pm 10\%, T_A = -40 \text{ to } 125 \text{ °C})$

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
VDD Undervoltage Threshold	VDDUV+	V_{DD1}, V_{DD2} rising	2.15	2.3	2.5	V
VDD Negative-Going Lockout Hysteresis	VDD _{HYS}		45	75	95	mV
Positive-Going Input Threshold	VT+	All inputs rising	1.6	_	1.9	V
Negative-Going Input Threshold	VT–	All inputs falling	1.1		1.4	V
Input Hysteresis	V _{HYS}		0.40	0.45	0.50	V
High Level Input Voltage	V _{IH}		2.0		_	V
Low Level Input Voltage	V _{IL}		_	_	0.8	V
High Level Output Voltage	V _{OH}	loh = -4 mA	V _{DD1} ,V _{DD2} - 0.4	3.1	-	V
Low Level Output Voltage	V _{OL}	lol = 4 mA	_	0.2	0.4	V
Input Leakage Current	ΙL		_	_	±10	μA
Output Impedance (Si8410/20) ¹	Z _O		_	50	_	Ω
	DC Supply	Current (All inputs 0 V or	at supply)		1	1
Si8410Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.0	1.5	mA
V _{DD2}		All inputs 0 DC	_	1.0	1.5	
V _{DD1}		All inputs 1 DC	_	3.0	4.5	
V _{DD2}		All inputs 1 DC	—	1.0	1.5	
Si8420Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.3	2.0	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	5.8	8.7	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
Si8421Ax, Bx						
V _{DD1}		All inputs 0 DC		1.7	2.6	mA
V _{DD2}		All inputs 0 DC		1.7	2.6	
V _{DD1}		All inputs 1 DC		3.7	5.6	
V _{DD2}		All inputs 1 DC		3.7	5.6	
Si8422Ax, Bx						

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Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
V _{DD1}		All inputs 0 DC	_	3.7	5.6	mA
V _{DD2}		All inputs 0 DC	_	3.7	5.6	
V _{DD1}		All inputs 1 DC	_	1.7	2.6	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
Si8423Ax, Bx						
V _{DD1}		All inputs 0 DC	_	5.4	8.1	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	1.3	2.0	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
1 Mbps	Supply Current (All i	nputs = 500 kHz square wave	, C _L = 15 pF	on all outputs	s)	
Si8410Ax, Bx						
V _{DD1}			_	2.0	3.0	mA
V _{DD2}			_	1.1	1.7	
Si8420Ax, Bx						
V _{DD1}			_	3.5	5.3	mA
V _{DD2}			_	1.9	2.9	
Si8421Ax, Bx						
V _{DD1}			_	2.8	4.2	mA
V _{DD2}			_	2.8	4.2	
Si8422Ax, Bx						
V _{DD1}			_	2.8	4.2	mA
V _{DD2}			_	2.8	4.2	
Si8423Ax, Bx						
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	1.9	2.9	
10 Mbp	s Supply Current (All	l inputs = 5 MHz square wave	, C _L = 15 pF	on all outputs	5)	1
Si8410Bx						
V _{DD1}				2.0	3.0	mA
V _{DD2}			-	1.3	1.8	
Si8420Bx						
V _{DD1}			_	3.5	5.3	mA
V _{DD2}			-	2.3	3.2	
Si8421Bx						
V _{DD1}			_	3.0	4.4	mA
V _{DD2}			_	3.0	4.4	

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Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Si8422Bx						
V _{DD1}			—	3.0	4.4	mA
V _{DD2}			_	3.0	4.4	
Si8423Bx						
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	2.2	3.1	
100 Mbps Supply Current (All inpu	ts = 50 MHz squ	lare wave, C _L = 15 pF on all out	outs)			
Si8410Bx						
V _{DD1}			_	2.0	3.0	mA
V _{DD2}			_	3.6	4.5	
Si8420Bx						
V _{DD1}			_	4.5	5.3	mA
V _{DD2}			_	7.0	8.8	
Si8421Bx						
V _{DD1}			_	5.3	6.6	mA
V _{DD2}				5.3	6.6	
Si8422Bx				0.0	0.0	
V _{DD1}				5.3	6.6	mA
			_	5.3	6.6	
V _{DD2}				5.5	0.0	
Si8423Bx				2.4	F 4	
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	6.6	8.3	
		Timing Characteristics				
Si841xAx, Si842xAx			-			
Maximum Data Rate			0	—	1.0	Mbps
Minimum Pulse Width			_	—	250	ns
Propagation Delay	t _{PHL} , t _{PLH}	See Figure 5.1 Propagation Delay Timing on page 14	_	—	35	ns
Pulse Width Distortion	PWD	See Figure 5.1 Propagation	_		25	ns
tplh – tphl		Delay Timing on page 14				
Propagation Delay Skew ²	t _{PSK(P-P)}				40	ns
Channel-Channel Skew	t _{PSK}		_		35	ns
Si841xBx, Si842xBx						
Maximum Data Rate			0		150	Mbps
Minimum Pulse Width					6.0	ns
Propagation Delay	t _{PHL} , t _{PLH}	See Figure 5.1 Propagation Delay Timing on page 14	4.0	8.0	11	ns

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Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Pulse Width Distortion	PWD	See Figure 5.1 Propagation Delay Timing on page 14	_	1.5	3.0	ns
t _{PLH} – t _{PHL}		Delay mining on page 14				
Propagation Delay Skew ²	t _{PSK(P-P)}		—	2.0	3.0	ns
Channel-Channel Skew	t _{PSK}		—	0.5	1.5	ns
All Models						
Output Rise Time	t _r	C _L = 15 pF		2.0	4.0	ns
Output Fall Time	t _f	C _L = 15 pF	—	2.0	4.0	ns
Peak Eye Diagram Jitter	t _{JIT(PK)}	See Figure 3.3 Eye Diagram on page 5		350	_	ps
Common Mode Transient Immunity	CMTI	V _I = V _{DD} or 0 V	20	45	_	kV/µs
Start-up Time ³	t _{SU}		—	15	40	μs

Notes:

1. The nominal output impedance of an isolator driver channel is approximately 50 Ω, ±40%, which is a combination of the value of the on-chip series termination resistor and channel resistance of the output driver FET. When driving loads where transmission line effects will be a factor, output pins should be appropriately terminated with controlled impedance PCB traces.

2. t_{PSK(P-P)} is the magnitude of the difference in propagation delay times measured between different units operating at the same supply voltages, load, and ambient temperature.

3. Start-up time is the time period from the application of power to valid data at the output.

Table 5.4. Electrical Characteristics¹

(V_{DD1} = 2.70 V, V_{DD2} = 2.70 V, T_A = –40 to 125 °C)

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
VDD Undervoltage Threshold	VDDUV+	V_{DD1}, V_{DD2} rising	2.15	2.3	2.5	V
VDD Negative-Going Lockout Hysteresis	VDD _{HYS}		45	75	95	mV
Positive-Going Input Threshold	VT+	All inputs rising	1.6	_	1.9	V
Negative-Going Input Threshold	VT–	All inputs falling	1.1		1.4	V
Input Hysteresis	V _{HYS}		0.40	0.45	0.50	V
High Level Input Voltage	V _{IH}		2.0	_	_	V
Low Level Input Voltage	V _{IL}		_	_	0.8	V
High Level Output Voltage	V _{OH}	loh = -4 mA	V _{DD1} ,V _{DD2} - 0.4	2.3	-	V
Low Level Output Voltage	V _{OL}	lol = 4 mA	_	0.2	0.4	V
Input Leakage Current	١L		_	_	±10	μA
Output Impedance ²	Z _O		_	50	_	Ω
	DC Supply	Current (All inputs 0 V or	at supply)			
Si8410Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.0	1.5	mA
V _{DD2}		All inputs 0 DC	_	1.0	1.5	
V _{DD1}		All inputs 1 DC	_	3.0	4.5	
V _{DD2}		All inputs 1 DC	—	1.0	1.5	
Si8420Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.3	2.0	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	5.8	8.7	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
Si8421Ax, Bx						
V _{DD1}		All inputs 0 DC	_	1.7	2.6	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	3.7	5.6	
V _{DD2}		All inputs 1 DC	_	3.7	5.6	
Si8422Ax, Bx						

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Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
V _{DD1}		All inputs 0 DC	-	3.7	5.6	mA
V _{DD2}		All inputs 0 DC	—	3.7	5.6	
V _{DD1}		All inputs 1 DC	_	1.7	2.6	
V _{DD2}		All inputs 1 DC	_	1.7	2.6	
Si8423Ax, Bx						
V _{DD1}		All inputs 0 DC	_	5.4	8.1	mA
V _{DD2}		All inputs 0 DC	_	1.7	2.6	
V _{DD1}		All inputs 1 DC	_	1.3	2.0	
V _{DD2}		All inputs 1 DC	—	1.7	2.6	
	ps Supply Current (All in	puts = 500 kHz square wav	e, C _L = 15 pF	on all outputs	s)	
Si8410Ax, Bx		· · · · · · · · · · · · · · · · · · ·				
V _{DD1}			_	2.0	3.0	mA
V _{DD2}			_	1.1	1.7	
Si8420Ax, Bx						
V _{DD1}			_	3.5	5.3	mA
V _{DD2}			_	1.9	2.9	
Si8421Ax, Bx						
V _{DD1}			_	2.8	4.2	mA
V _{DD2}			_	2.8	4.2	
Si8422Ax, Bx						
V _{DD1}			_	2.8	4.2	mA
V _{DD2}			_	2.8	4.2	
Si8423Ax, Bx						
V _{DD1}			_	3.3	5.0	mA
V _{DD2}			_	1.8	2.8	
10 M	Ibps Supply Current (All i	nputs = 5 MHz square wav	e, C _L = 15 pF	on all outputs	5)	
Si8410Bx						
V _{DD1}			_	2.0	3.0	mA
V _{DD2}			_	1.1	1.7	
Si8420Bx						
V _{DD1}			_	3.5	5.3	mA
V _{DD2}			_	2.1	3.0	
Si8421Bx						
V _{DD1}			_	2.9	4.3	mA
V _{DD2}			-	2.9	4.3	

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Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Si8422Bx						
V _{DD1}			_	2.9	4.3	mA
V _{DD2}			_	2.9	4.3	
Si8423Bx						
V _{DD1}			—	3.4	5.1	mA
V _{DD2}			—	2.0	2.9	
100 Mbps Su	pply Current (A	II inputs = 50 MHz square wave	, CL = 15 pF	on all outpu	ts)	
Si8410Bx						
V _{DD1}			—	2.0	3.0	mA
V _{DD2}			—	2.0	3.0	
Si8420Bx						
V _{DD1}			_	3.5	5.3	mA
V _{DD2}			_	5.5	6.9	
Si8421Bx						
V _{DD1}			_	4.6	5.8	mA
V _{DD2}			_	4.6	5.8	
Si8422Bx						
V _{DD1}			_	4.6	5.8	mA
V _{DD2}			_	4.6	5.8	
Si8423Bx						
V _{DD1}			_	3.4	5.1	mA
V _{DD2}			_	5.2	6.5	
		Timing Characteristics				
Si841xAx, Si842xAx						
Maximum Data Rate			0		1.0	Mbps
Minimum Pulse Width			_		250	ns
Propagation Delay	t _{PHL} , t _{PLH}	See Figure 5.1 Propagation Delay Timing on page 14	_	_	35	ns
Pulse Width Distortion	PWD	See Figure 5.1 Propagation	_	_	25	ns
t _{PLH} - t _{PHL}		Delay Timing on page 14				
Propagation Delay Skew ³	t _{PSK(P-P)}		_	_	40	ns
Channel-Channel Skew	t _{PSK}		_		35	ns
Si841xBx, Si842xBx		1		1	I	1
Maximum Data Rate			0		150	Mbps
Minimum Pulse Width					6.0	ns
Propagation Delay	t _{PHL} , t _{PLH}	See Figure 5.1 Propagation Delay Timing on page 14	4.0	8.0	11	ns

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Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Pulse Width Distortion	PWD	See Figure 5.1 Propagation		1.5	3.0	ns
t _{PLH} - t _{PHL}		Delay Timing on page 14				
Propagation Delay Skew ³	t _{PSK(P-P)}		_	2.0	3.0	ns
Channel-Channel Skew	t _{PSK}		_	0.5	1.5	ns
All Models					1	
Output Rise Time	t _r	C _L = 15 pF	_	2.0	4.0	ns
Output Fall Time	t _f	C _L = 15 pF	_	2.0	4.0	ns
Peak Eye Diagram Jitter	t _{JIT(PK)}	See Figure 3.3 Eye Diagram on page 5	_	350	_	ps
Common Mode Transient Immunity	CMTI	V _I = V _{DD} or 0 V	20	45	_	kV/µs
Start-up Time ⁴	t _{SU}		_	15	40	μs

Notes:

1. Specifications in this table are also valid at VDD1 = 2.6 V and VDD2 = 2.6 V when the operating temperature range is constrained to $T_A = 0$ to 85 °C.

2. The nominal output impedance of an isolator driver channel is approximately 50 Ω , ±40%, which is a combination of the value of the on-chip series termination resistor and channel resistance of the output driver FET. When driving loads where transmission line effects will be a factor, output pins should be appropriately terminated with controlled impedance PCB traces.

3. t_{PSK(P-P)} is the magnitude of the difference in propagation delay times measured between different units operating at the same supply voltages, load, and ambient temperature.

4. Start-up time is the time period from the application of power to valid data at the output.

Table 5.5. Regulatory Information¹

CSA

The Si84xx is certified under CSA Component Acceptance Notice 5A. For more details, see File 232873.

61010-1: Up to 600 V_{RMS} reinforced insulation working voltage; up to 600 V_{RMS} basic insulation working voltage.

60950-1: Up to 600 V_{RMS} reinforced insulation working voltage; up to 1000 V_{RMS} basic insulation working voltage.

60601-1: Up to 125 V_{RMS} reinforced insulation working voltage; up to 380 V_{RMS} basic insulation working voltage.

VDE

The Si84xx is certified according to IEC 60747-5-5. For more details, see File 5006301-4880-0001.

60747-5-5: Up to 891 V_{peak} for basic insulation working voltage.

60950-1: Up to 600 V_{RMS} reinforced insulation working voltage; up to 1000 V_{RMS} basic insulation working voltage.

UL

The Si84xx is certified under UL1577 component recognition program. For more details, see File E257455.

Rated up to 5000 $V_{\mbox{RMS}}$ isolation voltage for basic insulation.

Note:

1. Regulatory Certifications apply to 2.5 kV_{RMS} rated devices which are production tested to 3.0 kV_{RMS} for 1 sec. Regulatory Certifications apply to 5.0 kV_{RMS} rated devices which are production tested to 6.0 kV_{RMS} for 1 sec. For more information, see Section 2. Ordering Guide.

Table 5.6.	Insulation	and Safety-Related	Specifications
------------	------------	--------------------	----------------

Parameter	Symbol	Test Condi-	Val	Unit	
		tion	WB SOIC-16	NB SOIC-8	
Nominal Air Gap (Clearance) ¹	L(IO1)		8.0 min	4.9 min	mm
Nominal External Tracking (Creepage) ¹	L(IO2)		8.0 min	4.01 min	mm
Minimum Internal Gap (Internal Clearance)			0.014	0.008	mm
Tracking Resistance (Proof Tracking Index)	PTI	IEC60112	600	600	V _{RMS}
Erosion Depth	ED		0.019	0.040	mm
Resistance (Input-Output) ²	R _{IO}		10 ^{1,2}	10 ^{1,2}	Ω
Capacitance (Input-Output) ²	C _{IO}	f = 1 MHz	2.0	1.0	pF
Input Capacitance ³	CI		4.0	4.0	pF

Notes:

1. The values in this table correspond to the nominal creepage and clearance values as detailed in Section 7.1 Package Outline (16-Pin Wide Body SOIC) and Section 7.2 Package Outline (8-Pin Narrow Body SOIC). VDE certifies the clearance and creepage limits as 8.5 mm minimum for the WB SOIC-16 package and 4.7 mm minimum for the NB SOIC-8 package. UL does not impose a clearance and creepage minimum for component level certifications. CSA certifies the clearance and creepage limits as 3.9 mm minimum for the NB SOIC-8 and 7.6 mm minimum for the WB SOIC-16 package.

2. To determine resistance and capacitance, the Si84xx is converted into a 2-terminal device. Pins 1–8 (1–4, NB SOIC-8) are shorted together to form the first terminal and pins 9–16 (5–8, NB SOIC-8) are shorted together to form the second terminal. The parameters are then measured between these two terminals.

3. Measured from input pin to ground.

Parameter	Symbol	Test Condi-	Charao	cteristic	Unit
		tion	WB SOIC-16	NB SOIC-8	
Maximum Working Insulation Voltage	V _{IORM}		891	560	Vpeak
Input to Output Test Voltage		$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	1671	1050	
Transient Overvoltage	V _{IOTM}	t = 60 sec	6000	4000	Vpeak
Pollution Degree (DIN VDE 0110, Table 1)			2	2	
Insulation Resistance at T_S , V_{IO} = 500 V	R _S		>10 ⁹	>10 ⁹	Ω

Table 5.7. IEC 60747-5-5 Insulation Characteristics for Si84xxxx¹

Table 5.8. IEC Safety Limiting Values¹

Parameter	Symbol	Test Condi-	M	Unit	
		tion	WB SOIC-16	NB SOIC-8	
Case Temperature	T _S		150	150	°C
Safety Input, Output, or Supply Current	IS	$\begin{array}{c} \theta_{JA} = 140 \\ ^{\circ}C/W \ (NB \\ SOIC-8), \ 100 \\ ^{\circ}C \ (WB \ SO- \\ IC-16), \\ V_{I} = 5.5 \ V, \ T_{J} \\ = 150 \ ^{\circ}C, \ T_{A} \\ = 25 \ ^{\circ}C \end{array}$	220	160	mA
Device Power Dissipation ²	PD		150	150	mW

Notes:

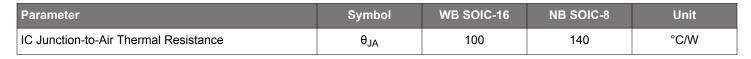
1. Maximum value allowed in the event of a failure; also see the thermal derating curve in Figure 5.2 (WB SOIC-16) Thermal Derating Curve, Dependence of Safety Limiting Values with Solar Terman DN SN 602747.5 Second Signal Sig

with Case Temperature per DIN EN 60747-5-5 on page 25 and Figure 5.3 (NB SOIC-8) Thermal Derating Curve, Dependence of Safety Limiting Values

with Case Temperature per DIN EN 60747-5-5 on page 25.

2. The Si84xx is tested with VDD1 = VDD2 = 5.5 V, T_J = 150 °C, C_L = 15 pF, input a 150 Mbps 50% duty cycle square wave.

Table 5.9. Thermal Characteristics



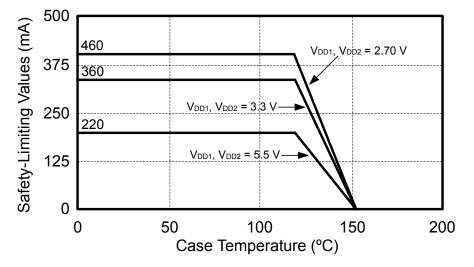


Figure 5.2. (WB SOIC-16) Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN EN 60747-5-5

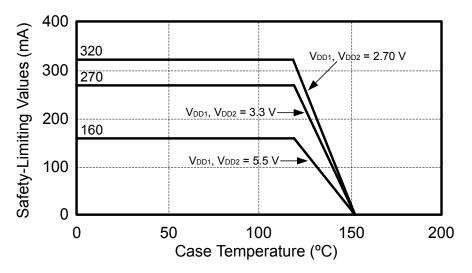


Figure 5.3. (NB SOIC-8) Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN EN 60747-5-5

Table 5.10. Absolute Maximum Ratings¹

Parameter	Symbol	Min	Тур	Max	Unit
Storage Temperature ²	T _{STG}	-65	_	150	C°
Operating Temperature	T _A	-40	_	125	C°
Junction Temperature	TJ	_	_	150	°C
Supply Voltage	V _{DD1} , V _{DD2}	-0.5	_	6.0	V
Input Voltage	VI	-0.5	_	V _{DD} + 0.5	V
Output Voltage	V _O	-0.5	_	V _{DD} + 0.5	V
Output Current Drive Channel	Ι _Ο	_	_	10	mA
Lead Solder Temperature (10 s)		_	_	260	C°
Maximum Isolation Voltage (1 s) NB SOIC-8		_	_	4500	V _{RMS}
Maximum Isolation Voltage (1 s) WB SO- IC-16		-	-	6500	V _{RMS}

Notes:

1. Permanent device damage may occur if the above absolute maximum ratings are exceeded. Functional operation should be restricted to conditions as specified in the operational sections of this data sheet.

2. VDE certifies storage temperature from -40 to 150 °C.

Si8410/20/21 (5 kV) Si8422/23/24/25/26 (2.5 & 5 kV) Data Sheet • Pin Descriptions

6. Pin Descriptions

6.1 Pin Descriptions (Wide-Body SOIC)

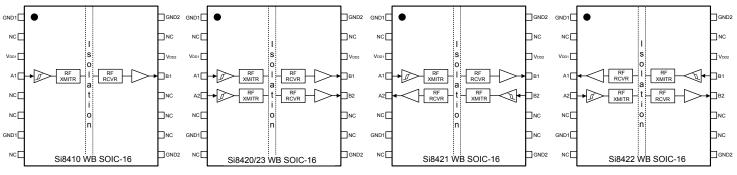


Figure 6.1. Wide-Body SOIC

Table 6.1. Pin Descriptions

Name	SOIC-16 Pin#	SOIC-16 Pin#	Туре	Description
	Si8410	Si842x		
GND1	1	1	Ground	Side 1 ground.
NC ¹	2, 5, 6, 8,10, 11, 12, 15	2, 6, 8,10, 11, 15	No Connect	NC
V _{DD1}	3	3	Supply	Side 1 power supply.
A1	4	4	Digital I/O	Side 1 digital input or output.
A2	NC	5	Digital I/O	Side 1 digital input or output.
GND1	7	7	Ground	Side 1 ground.
GND2	9	9	Ground	Side 2 ground.
B2	NC	12	Digital I/O	Side 2 digital input or output.
B1	13	13	Digital I/O	Side 2 digital input or output.
V _{DD2}	14	14	Supply	Side 2 power supply.
GND2	16	16	Ground	Side 2 ground.
: No Connect Th	ese pins are not internall	v connected They are	be left fleeting tigt to	

6.2 Pin Descriptions (Narrow-Body SOIC)

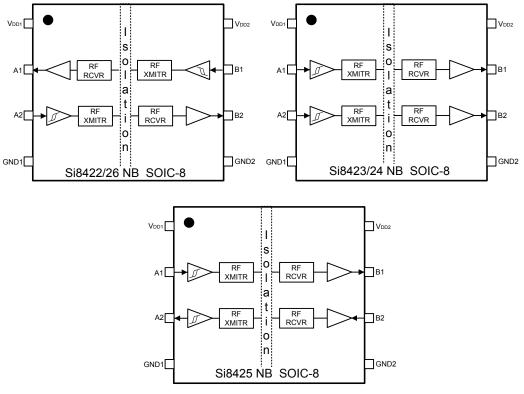


Figure 6.2. Narrow-Body SOIC

Name	SOIC-8 Pin#	Туре	Description
	Si842x		
V _{DD1}	1	Supply	Side 1 power supply.
GND1	4	Ground	Side 1 ground.
A1	2	Digital I/O	Side 1 digital input or output.
A2	3	Digital I/O	Side 1 digital input or output.
B1	7	Digital I/O	Side 2 digital input or output.
B2	6	Digital I/O	Side 2 digital input or output.
V _{DD2}	8	Supply	Side 2 power supply.
GND2	5	Ground	Side 2 ground.

Si8410/20/21 (5 kV) Si8422/23/24/25/26 (2.5 & 5 kV) Data Sheet • Package Outlines

7. Package Outlines

7.1 Package Outline (16-Pin Wide Body SOIC)

The figure below illustrates the package details for the Si84xx Digital Isolator. The table below lists the values for the dimensions shown in the illustration.

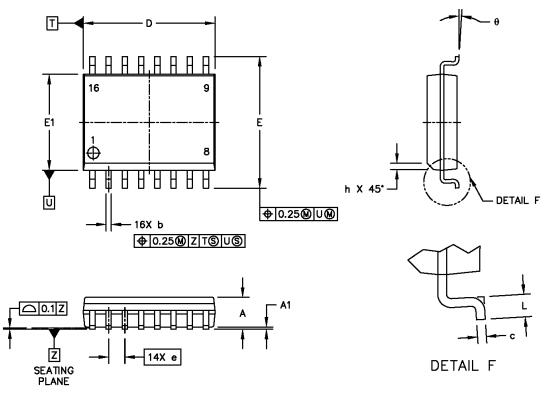


Figure 7.1. 16-Pin Wide Body SOIC

 Table 7.1. Package Diagram Dimensions

Symbol	Millimeters								
	Min	Max							
A	—	2.65							
A1	0.1	0.3							
D	10.3	BSC							
E	10.3 BSC								
E1	7.5 BSC								
b	0.31	0.51							
с	0.20	0.33							
e	1.27	BSC							
h	0.25	0.75							
L	0.4	1.27							
θ	0°	7°							

7.2 Package Outline (8-Pin Narrow Body SOIC)

The figure below illustrates the package details for the Si84xx. The table below lists the values for the dimensions shown in the illustration.

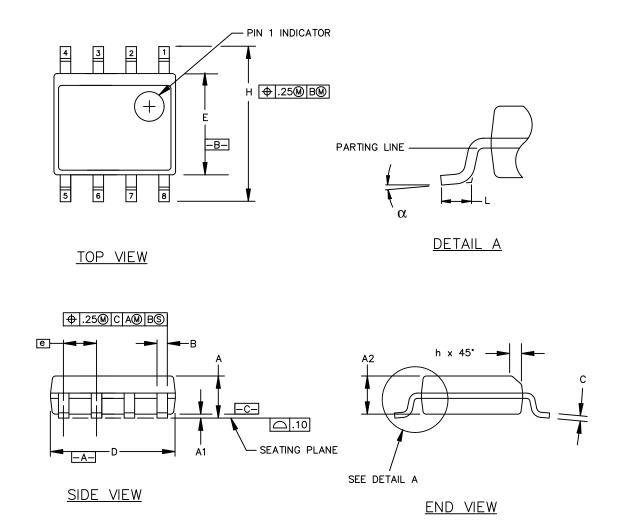


Figure 7.2. 8-pin Small Outline Integrated Circuit (SOIC) Package

Symbol	Millin	neters
	Min	Мах
A	1.35	1.75
A1	0.10	0.25
A2	1.40 REF	1.55 REF
В	0.33	0.51
С	0.19	0.25
D	4.80	5.00
E	3.80	4.00
e	1.27	BSC
н	5.80	6.20
h	0.25	0.50
L	0.40	1.27
α	0°	8°

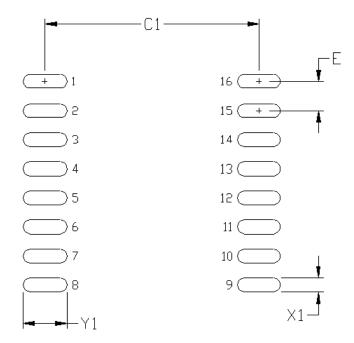
Table 7.2. Package Diagram Dimensions

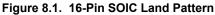
Si8410/20/21 (5 kV) Si8422/23/24/25/26 (2.5 & 5 kV) Data Sheet • Land Patterns

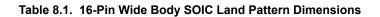
8. Land Patterns

8.1 Land Pattern (16-Pin Wide-Body SOIC)

The figure below illustrates the recommended land pattern details for the Si84xx in a 16-pin wide-body SOIC. The table below lists the values for the dimensions shown in the illustration.







Dimension	(mm)	
C1	Pad Column Spacing	9.40
E	Pad Row Pitch	1.27
X1	Pad Width	0.60
Y1	Pad Length	1.90
Notes:		

1. This Land Pattern Design is based on IPC-7351 pattern SOIC127P1032X265-16AN for Density Level B (Median Land Protrusion).

2. All feature sizes shown are at Maximum Material Condition (MMC) and a card fabrication tolerance of 0.05 mm is assumed.

8.2 Land Pattern (8-Pin Narrow Body SOIC)

The figure below illustrates the recommended land pattern details for the Si84xx in an 8-pin narrow-body SOIC. The table below lists the values for the dimensions shown in the illustration.

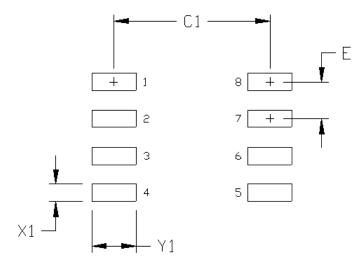


Figure 8.2. PCB Land Pattern: 8-Pin Narrow Body SOIC

Table 8.2. PCM Land Pattern Dimensions (8-Pin Narrow Body SOIC)

Dimension	Feature	(mm)
C1	Pad Column Spacing	5.40
E	Pad Row Pitch	1.27
X1	Pad Width	0.60
Y1	Pad Length	1.55
Notos	•	

Notes:

1. This Land Pattern Design is based on IPC-7351 pattern SOIC127P600X173-8N for Density Level B (Median Land Protrusion).

2. All feature sizes shown are at Maximum Material Condition (MMC) and a card fabrication tolerance of 0.05 mm is assumed.

Si8410/20/21 (5 kV) Si8422/23/24/25/26 (2.5 & 5 kV) Data Sheet • Top Markings

9. Top Markings

9.1 Top Marking (16-Pin Wide Body SOIC)

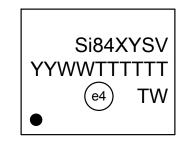




Table 9.1. Top Marking Explanation

Line 1 Marking:	Base Part Number	Si84 = Isolator product series
	Ordering Options	XY = Channel Configuration
	(See 2. Ordering Guide for more information).	X = # of data channels (2, 1)
		Y = # of reverse channels $(1, 0)^{1,2}$
		S = Speed Grade
		A = 1 Mbps
		B = 150 Mbps
		V = Insulation rating
		A = 1 kV; B = 2.5 kV; C = 3.75 kV; D = 5 kV
Line 2 Marking:	YY = Year	Assigned by assembly subcontractor. Corresponds to the year
	WW = Workweek	and workweek of the mold date.
	TTTTTT = Mfg Code	Manufacturing code from assembly house.
Line 3 Marking:	Circle = 1.7 mm Diameter	"e4" Pb-Free Symbol.
	(Center-Justified)	
	Country of Origin ISO Code Abbreviation	TW = Taiwan.

1. The Si8422 has one reverse channel.

2. The Si8423 has zero reverse channels.

9.2 Top Marking (8-Pin Narrow-Body SOIC)

Si84XYSV YWWRF AIXX e3 Ο

Figure 9.2. Isolator Top Marking

Base Part Number	Si84 = Isolator product series							
Ordering Options	XY = Channel Configuration X = # of data channels (2, 1)							
(See 2. Ordering Guide for more information).								
	Y = Channel configuration (0, 1, 2, 3, 4, 5, 6) ^{1,}							
	S = Speed Grade							
	A = 1 Mbps							
	B = 150 Mbps							
	V = Insulation rating							
	A = 1 kV; B = 2.5 kV; C = 3.75 kV; D = 5 kV							
YY = Year	Assigned by assembly subcontractor. Corresponds to the year							
WW = Workweek	and workweek of the mold date.							
R = Product (OPN) Revision								
F = Wafer Fab								
Circle = 1.1 mm Diameter	"e3" Pb-Free Symbol.							
Left-Justified	First two characters of the manufacturing code.							
A = Assembly Site	Last four characters of the manufacturing code.							
I = Internal Code								
XX = Serial Lot Number								
	Ordering Options (See 2. Ordering Guide for more information). YY = Year WW = Workweek R = Product (OPN) Revision F = Wafer Fab Circle = 1.1 mm Diameter Left-Justified A = Assembly Site I = Internal Code							

Notes:

1. See section 6.2 Pin Descriptions (Narrow-Body SOIC) for pinout description and section 2. Ordering Guide for default output state.

10. Revision History

Revision 1.4

August 2020

- · Updated data sheet format.
- Added new OPNs.
- Updated Revision History format.

Revision 1.3

- · Added references to AEC-Q100 qualified throughout.
- Changed all 60747-5-2 references to 60747-5-5.
- Updated Table 2.1 Ordering Guide^{1,2,3} on page 3.
 - Added table notes 1 and 2.
 - · Removed references to moisture sensitivity levels.
 - Added Revision D ordering information.
 - Removed older revisions.
- Updated Section 9.1 Top Marking (16-Pin Wide Body SOIC).

Revision 1.2

• Updated Timing Characteristics in Table 5.2 Electrical Characteristics on page 10 through Table 5.4 Electrical Characteristics¹ on page 19.

Revision 1.1

- · Numerous text edits.
- Added table notes to Table 9.1 Top Marking Explanation on page 34 and Table 9.2 Top Marking Explanation on page 35.

Revision 1.0

- · Updated features list.
 - Updated transient immunity.
- · Removed block diagram from front page.
- Added chip graphics on front page.
- Added Peak Eye Diagram jitter in Table 5.2 Electrical Characteristics on page 10 through Table 5.4 Electrical Characteristics¹ on page 19.
- Updated transient immunity
- Moved Table 4.1 Si84xx Logic Operation Table on page 6 to Section 4. Device Operation.
- Added Section 4. Device Operation.
- · Added Section 4.4 Fail-Safe Operating Mode.
- Moved Section 4.5 Typical Performance Characteristics.
- · Deleted RF Radiated Emissions section.
- · Deleted RF Magnetic and Common-Mode Transient Immunity section.
- Updated MSL rating to MSL2A.

Revision 0.1

· Initial release.

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